

Fig.2

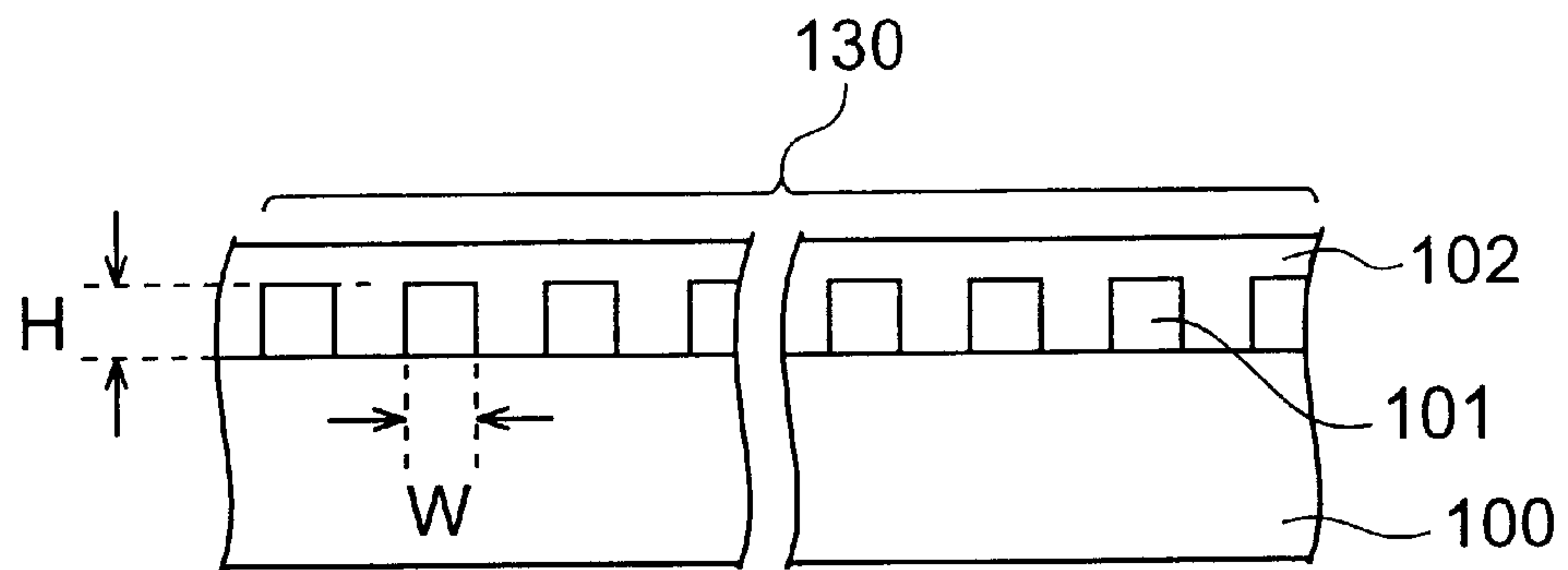


Fig.3

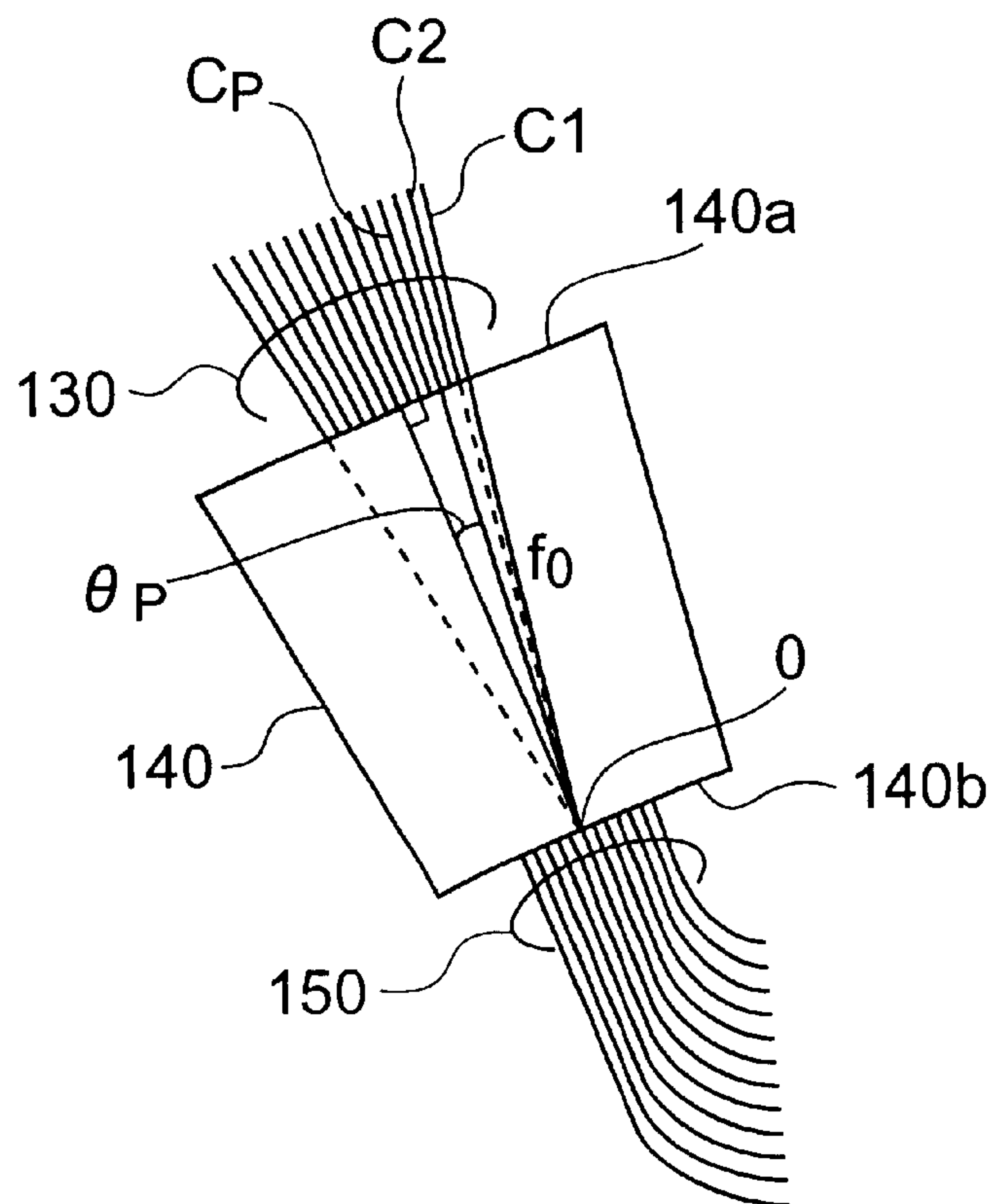


Fig.4

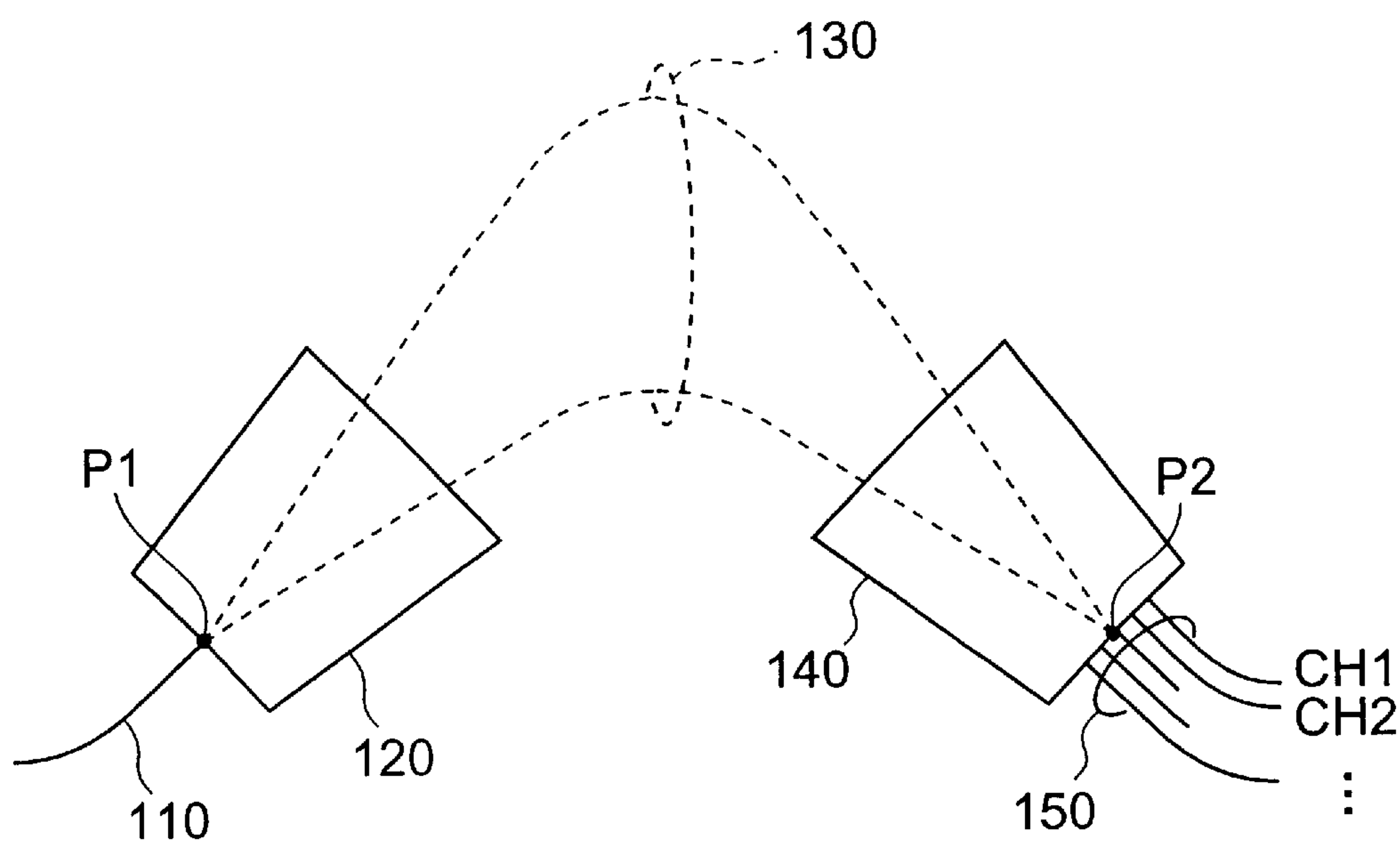


Fig.5A

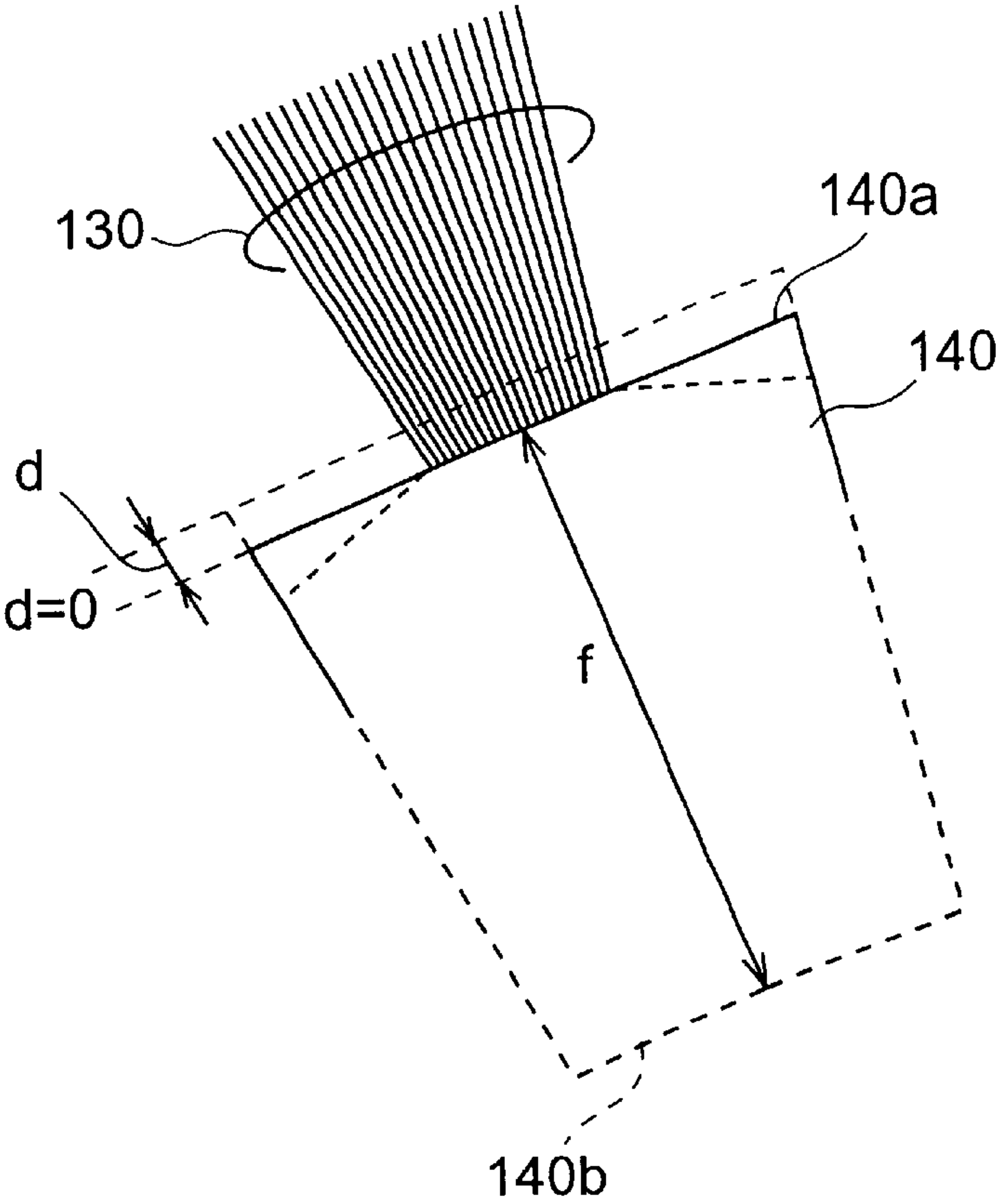


Fig.5B

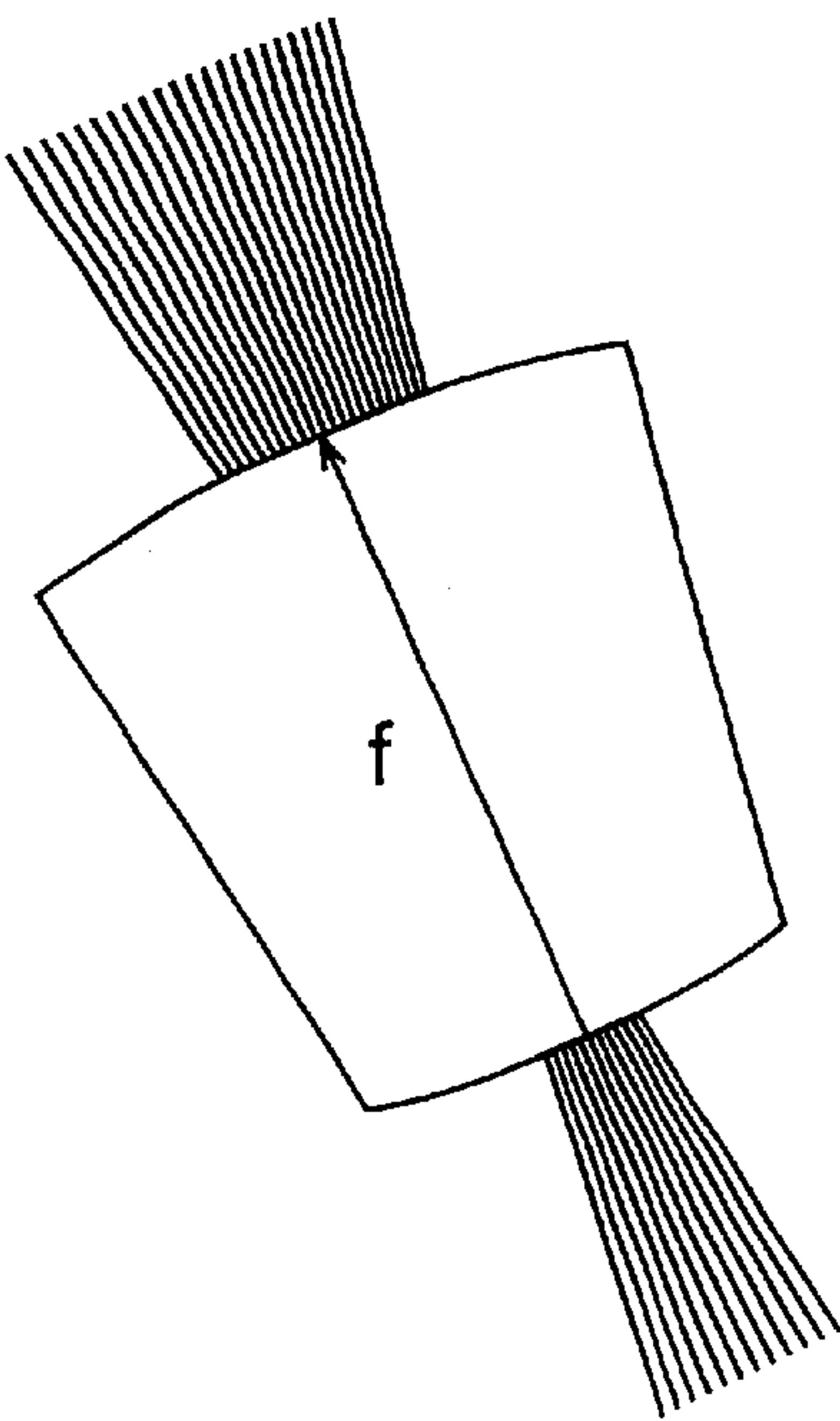
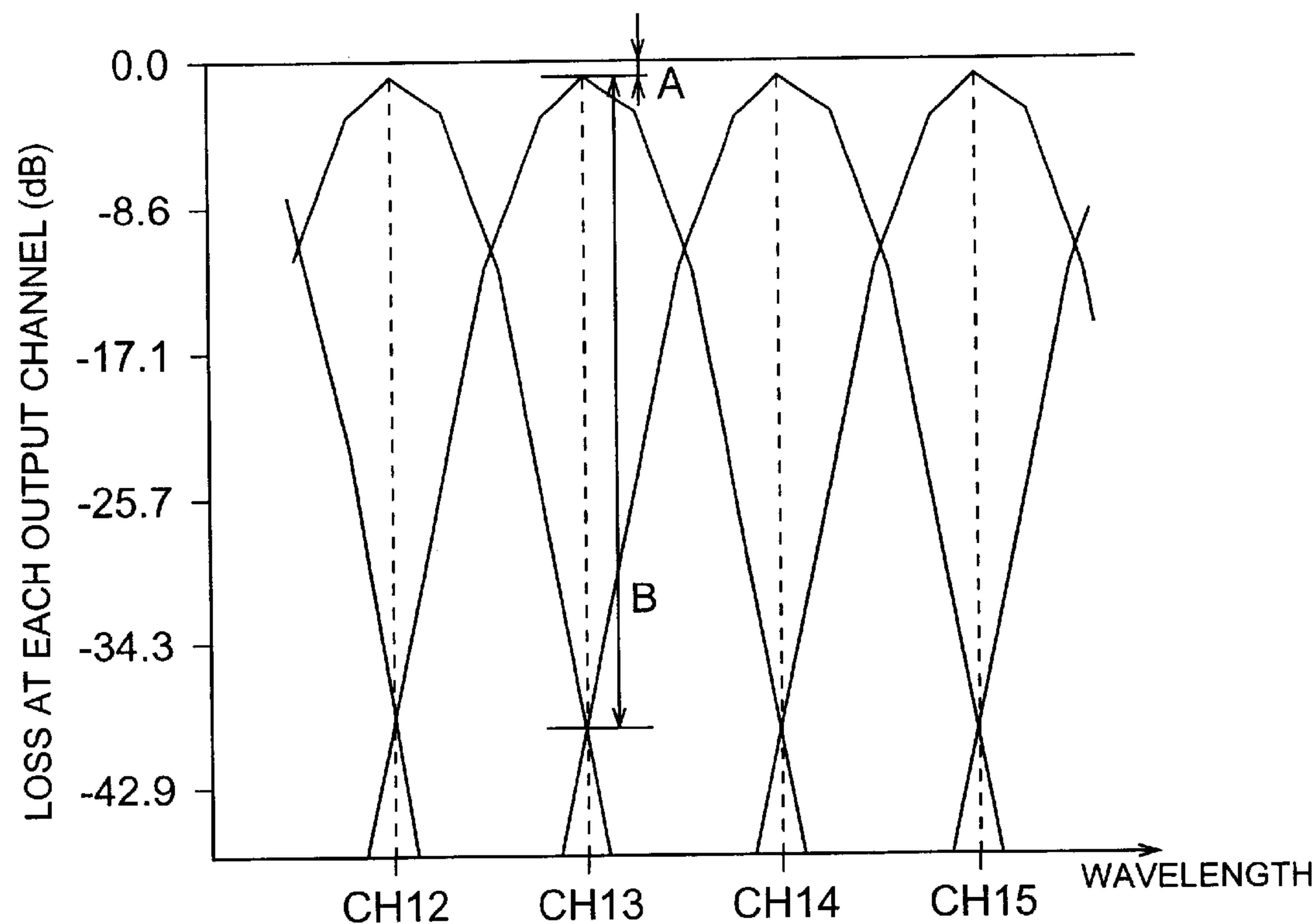


Fig.6



Specifically, with respect to the average value obtained from respective optical path length differences between all adjacent channel waveguides in the n channel waveguides, it is preferred that the maximum deviation of optical path length difference between adjacent channel waveguides in the n channel waveguides be set to 3% or more. It means that, letting ΔL_k ($k=1$ to $(n-1)$) be each optical path length difference between adjacent channel waveguides, ΔL_{MAX} be the maximum optical path length difference (or minimum optical path length difference) between adjacent channel waveguides, and ΔL_{AVE} be the average value of optical path length difference, at least the deviation η (maximum deviation) of maximum optical path length difference

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the configuration near a slab waveguide of a sample manufactured as a comparative example;

FIG. 6 is a loss spectrum measured at each output waveguide (output channel) of the sample (FIG. 5A) manufactured as an embodiment of the optical multiplexer/demultiplexer according to the present invention;

FIG. 7 is a graph showing the insertion loss (dB) concerning a slab waveguide (FIG. 5A) of the sample manufactured as an embodiment of the optical multiplexer/demultiplexer according to the present invention when the distance between connecting end faces is changed by a width d (μm) with reference to the position (d=0) where the distance between the connecting end faces coincides with the slab length f;

FIG. 8 is a graph showing the crosstalk (dB) between output waveguides (output channels) concerning the slab waveguide (FIG. 5A) of the sample manufactured as an embodiment of the optical multiplexer/demultiplexer according to the present invention when the distance between connecting end faces is changed by a width d (μm) with reference to the position ($d=0$) where the distance between the connecting end faces coincides with the slab length f ; and

DESCRIPTION OF THE PREFERRED EMBODIMENTS

In the following, embodiments of the optical multiplexer/demultiplexer according to the present invention will be explained in detail with reference to FIGS. 1 to 4, 5A, 5B, and 6 to 9. Among the drawings, parts identical to each other will be referred to with numerals identical to each other without repeating their overlapping explanations.

FIG. 1 is a plan view showing the configuration of an AWG circuit as the optical multiplexer/demultiplexer according to the present invention. As depicted, this optical multiplexer/demultiplexer is an optical component in which optical waveguide parts are integrally formed on a silica glass substrate **100**. Namely, at least one input waveguide **110**, a first slab waveguide **120** (input slab waveguide), n (≥ 3) channel waveguides **130**, a second waveguide **140** (output slab waveguide), and output waveguides **150** corresponding to respective signal channels CH1, CH2, . . . CH15, and CH16 are disposed on the substrate **100**.

Each of the waveguide parts is doped with GeO_2 , whereas the doping amount of GeO_2 is such that the relative refractive index difference between the substrate **100** and the waveguide parts is 0.5% or more in order to make it possible to lower the radius of curvature of channel waveguides **130** (improve the light confinement efficiency). The substrate **100** is not restricted to the silica glass substrate, and may be constituted by a silicon substrate and a glass layer having a thickness of ten to several tens of micrometers formed on the silicon substrate. Similar operations and effects are also obtained when waveguides doped with GeO_2 are formed on this glass layer. FIG. 2 is a view showing the cross-sectional structure of AWG circuit taken along the line I—I of FIG. 1, in which a core **101** (having a width W and a thickness (height) H) to be come a waveguide and a cladding **102** covering the core **101** are disposed on the substrate **100**.

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[illegible]

The input waveguide **110** is a waveguide for guiding to the first slab waveguide **120** individual signals having respective channel wavelengths which are set at predetermined wavelength intervals as signal channels, and has an output end optically connected to the optical input end face **120b** of first slab waveguide **120**. The channel waveguides **130** are waveguides having respective lengths different from each other, and are two-dimensionally arranged on the substrate **100**. The channel waveguides **130** are optically connected to the optical output end face **120a** of first slab waveguide **120** so as to sandwich the first slab waveguide **120** together with the input waveguide **110**, and are optically connected to the optical input end face **140a** of second slab waveguide **140** so as to sandwich the second slab waveguide **140** together with the output waveguides **150**. The output waveguides **150** are waveguides two-dimensionally arranged on the substrate **100** while in a state where respective optical output end face **140a** of second slab waveguide **140**, so as to correspond to individual signals having respective channel wavelengths set at predetermined wavelength intervals, i.e., so as to correspond to the respective signal channels.

Though the optical multiplexer/demultiplexer shown in FIG. 1 is explained as an AWG circuit, in which light successively propagates through the input waveguide **110**, first slab waveguide **120**, channel waveguides **130**, second slab waveguide **140**, and output waveguides **150**, enabling 16 channels of signals to be separated from each other, a plurality of input waveguides may be provided so as to correspond to the respective signal channels, thereby realizing an AWG circuit which enables wavelength multiplexing.

FIG. 3 is a plan view for explaining structural characteristics of the optical multiplexer/demultiplexer according to the present invention, mainly illustrating a waveguide structure of its optical output portion. Though the waveguide structure near the second slab waveguide **140** is shown in FIG. 3, the waveguides near the first slab waveguide **120** may also comprise a similar structure.

In the optical multiplexer/demultiplexer according to the present invention, for adjusting the focal position in the second slab waveguide **140**, the channel waveguides **130** connected to the optical input end face **140a** of second slab waveguide **140** are arranged such that the optical output ends thereof are directed to the center O of optical output end face **140b** of the second slab waveguide **140**. Here, since the optical input end face **140a** of second slab waveguide **140** is processed flat, thus connected channel waveguides **130** have connecting angles (angles formed between the channel waveguides **130** and optical input end face **140a**) different from each other at the optical output end of channel

waveguides **130** in the second slab waveguide **140** from its opposite connecting end face **140b** by a width d (0 to 1000 μm) with reference to the position ($d=0$) where the connecting end faces **140a**, **140b** are separated from each other by the slab length f as shown in FIG. 5A, the inventors measured the insertion loss at the signal channel CH15 (FIG. 7) and the crosstalk (dB) between output waveguides **150** (output channels). As a conventional level, each of FIGS. 7 and 8 also shows data of the second sample comprising slab waveguides having the structure shown in FIG. 5B.

As can be seen from FIG. 7, the first sample can suppress the insertion loss to a level on a par with the conventional level if the width d is 200 μm or less, whereas the insertion loss remarkably increases under the influence of coupling between the channel waveguides **130** and second slab waveguide **140** if the width d exceeds 200 μm . Hence, the fluctuation of width d as a manufacturing tolerance is unproblematic in practice if it does not exceed 200 μm .

As can be seen from FIG. 8, on the other hand, the crosstalk between adjacent channels is lower than the conventional level of second sample regardless of the change in width d .

Further, the inventors measured crosstalk while changing the degree of fluctuation (deviation) in optical path length difference between adjacent channel waveguides. Here, basic measurement conditions are similar to those mentioned above. The samples prepared are a third sample having the structure shown in FIG. 5A with a width d set to 100 μm , a fourth sample having the structure shown in FIG. 5A with a width d set to 1000 μm , and the second sample prepared as a comparative example. The fluctuation (defined by the maximum deviation η) in optical path length difference between adjacent waveguides is given by the following expression with respect to the average value ΔL_{AVE} obtained from all the optical path length differences ΔL_k ($k=1$ to $(n-1)$) between adjacent channel waveguides in the channel waveguides **130**:

$$\eta = \frac{|\Delta L_{AVE} - \Delta L_{MAX}|}{\Delta L_{AVE}}$$

where

$$\Delta L_{AVE} = \frac{\sum_{k=1}^{n-1} \Delta L_k}{n-1}$$

wherein ΔL_{AVE} is the maximum optical path length difference (or the minimum optical path length difference).

The maximum deviation is 0.042 (=4.2%) in the third sample and 0.046 (=4.6%) in the fourth sample. In the second sample, which is a comparative example, the maximum deviation is inevitably 0% since the optical path length difference between adjacent channel waveguides is constant.

FIG. 9 is a graph showing results of measurement of crosstalk in the above-mentioned second to fourth embodiments. As can be seen from this graph, crosstalk begins to decrease remarkably when the maximum deviation η exceeds about 0.03 (=3%). In view of this, the maximum deviation of optical path length difference between adjacent channel waveguides in the channel waveguides **130** in the optical multiplexer/demultiplexer according to the present invention is set to 3% or more with respect to the average value obtained from all the optical path length differences between the adjacent channel waveguides in the channel waveguides **130**.

As in the foregoing, the present invention is designed such that, while channel waveguides adjacent each other are allowed to have optical path length differences different from each other, optical paths traveling by way of respective channel waveguides adjacent each other have a constant effective optical path length difference as the optical paths including the slab waveguides in total. Therefore, the structure for connecting channel waveguides to flat connecting end faces of slab waveguides can be changed arbitrarily without being restricted by multi/demultiplexing conditions. As a result, it becomes easier to design the arrangement of channel waveguides, and their layout attains a higher degree of freedom, which is effective in making it possible to design a structure for further lowering the crosstalk between adjacent signal channels in output waveguides located in the periphery in particular among the output waveguides provided so as to correspond to respective signal channels.

What is claimed is:

1. An optical multiplexer/demultiplexer comprising:

a substrate;

first and second slab waveguides, each having a predetermined slab length, disposed on said substrate;

at least one input waveguide, disposed on said substrate, having an optical output end optically connected to an optical input end face of said first slab waveguide;

a plurality of output waveguides two-dimensionally arranged on said substrate while in a state where respective optical input ends thereof are optically connected to an optical output end face of said second slab waveguide, said output waveguides being provided so as to correspond to respective signal channels having wavelengths different from each other; and

n (≥ 3) channel waveguides two-dimensionally arranged on said substrate while in a state where an optical input end of each channel waveguide is optically connected to an optical output end face of said first slab waveguide so as to sandwich said first slab waveguide together with said input waveguide whereas an optical output end of each channel waveguide is optically connected to an optical input end face of said second slab waveguide so as to sandwich said second slab waveguide together with said output waveguides, said channel waveguides having respective lengths different from each other;

wherein a first channel waveguide selected from said n channel waveguides and a second channel waveguide adjacent said first channel waveguide on one side thereof have an optical path length difference therebetween different from that between said first channel waveguide and a third channel waveguide adjacent said first channel waveguide on the other side thereof, and wherein at least one of said optical output end face of said first slab waveguide and said optical input end face of said second slab waveguide each connected to said n channel waveguides has a form extending along a straight line intersecting said n channel waveguides.

2. An optical multiplexer/demultiplexer according to claim 1, wherein adjacent channel waveguides in said n channel waveguides have a maximum deviation of optical path length difference of 3% or more with respect to an average value obtained from all the optical path length differences between adjacent channels in said n channel waveguides.

3. An optical multiplexer/demultiplexer according to claim 1, wherein, with respect to at least one of said optical output end face of said first slab waveguide and said optical

